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| Search Notes  | Application/Control No. 10500562 | Applicant(s)/Patent Under Reexamination KAMEI, TOSHIO |
| | Examiner Yeh, Eueng-nan | Art Unit 2624 |

| SEARCHED | | | |
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| Class | Subclass | Date | Examiner |
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| SEARCH NOTES | | |
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| Search Notes | Date | Examiner |
| (382/173) text search - see search outputs | 2007/12/31 | ey |
| EAST text search - see search outputs | 2007/12/27 | ey |
| PALM inventor search - see search outputs | 2007/12/27 | ey |
| IEEE Xplore search - see search outputs | 2008/01/02 | ey |

| INTERFERENCE SEARCH | | | |
|---------------------|----------|------|----------|
| Class | Subclass | Date | Examiner |
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